# The optical and electrical properties of Eu<sup>3+</sup>-Y<sup>3+</sup>codoped ITO transparent conductive electrodes as luminescent solar concentrators

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## Abstract

Rare earth ions  $(Eu^{3+})$  and  $Y^{3+}$  ions were codoped into the tin-doped indium oxide (ITO) transparent conductive electrode to make it possess visible luminescent properties. The  $Eu^{3+}-Y^{3+}$  codoped transparent conductive thin films with the precise control on the desired stoichiometry of dopants were fabricated by sol-gel spin-coating technologies. We first report that the  $Eu^{3+}-Y^{3+}$  codoped ITO thin films show better visible luminescent properties than  $Eu^{3+}$ -doped ITO thin films. The higher  $Y^{3+}$  concentration can increase the 611 nm PL intensity of  $Eu^{3+}-Y^{3+}$  codoped ITO thin films. However, the  $Eu^{3+}$  and  $Y^{3+}$  codoping concentrations should be controlled within 0.1% and 0.5%, respectively, to avoid the deterioration of conductivity. We believe that the  $Eu^{3+}-Y^{3+}$  codoped ITO thin films can play dual roles as the luminescent solar concentrators and transparent conductive electrode to enhance the efficiency of solar cells.

Keywords: ITO, europium, yttrium, pyrocholre, photoluminescence.

# 1 Introduction

The luminescent solar concentrators (LSC) have attracted lots of attention for the efficiency enhancement of solar cell these past years [1–3]. Most of the LSC is the organic or inorganic fluorescent materials which were coated on the surface of solar cell devices [4–6]. However, this kind of LSC will increase the manufacturing procedures and cost. There is only 5% ultraviolet (UV) and near blue light (300~400 nm) that can reach the Earth surface [7] and most of the solar cells do not have good operating efficiency in this section because of the



absorption of transparent conductive electrode [8, 9]. Therefore we hope that the luminescent solar concentrators can convert this UV light to 500~700 nm visible light, which can be further absorbed by solar cell.

In this study, we try to codope  $Eu^{3+}$  and  $Y^{3+}$  ions into the transparent conductive electrode, tin-doped indium oxide (ITO), to make them possess visible luminescent properties. These  $Eu^{3+}-Y^{3+}$  codoped ITO thin films with the precise control on the desired stoichiometry of dopants were fabricated by solgel spin-coating technologies. In order to maintain the conductivity of  $Eu^{3+}-Y^{3+}$ codoped ITO thin films, the doping concentrations of  $Eu^{3+}$  and  $Y^{3+}$  ions were kept at a low contents, i.e.  $Eu^{3+}$  (0.1 mol%) and  $Y^{3+}$  (0~4 mol%). Optical and electrical properties such as fluorescence and sheet resistance (ohms/square) of the resulting  $Eu^{3+}$ -doped ITO system were systematically examined in terms of the codoping concentrations and structural evolution of the films at 600°C annealing for 1 h.

# 2 Experiments

### 2.1 Preparation of precursor solutions

The precursor solutions for the fabrication of  $Eu^{3+}-Y^{3+}$  codoped ITO thin films and powders were synthesized by following procedures. The starting materials is anhydrous indium trichloride (InCl<sub>3</sub>, 99.995%, Acros) which was dissolved in the mixture of acetic acid (HAc, CH<sub>3</sub>COOH, 99.5%, Acros) and 2methoxyethanol (2-MOE, C<sub>3</sub>H<sub>8</sub>O, 99.5%, Merck) with molar ratio of In/HAc/2-MOE=1/20/12. Then the solution was refluxed at 80°C for 3 h. Anhydrous tin chloride (SnCl<sub>4</sub>, 99%, Acros) was dissolved in ethanol (C<sub>2</sub>H<sub>5</sub>OH, 99.9%, JT-Baker), which was dropped into the refluxed indium solution at room temperature.

Finally, the yttrium acetate  $[Y(CH_3COO)_3 . 4H_2O, 99.9\%, Alfa]$  and europium nitrate  $[Eu(NO_3)_3 . 6H_2O, 99.9\%, Alfa]$  were dissolved in the solution (a mixture of methanol (CH<sub>3</sub>OH,  $\geq$ 99.5%, Merck) and ethylene glycol (HOCH<sub>2</sub>CH(OH)CH<sub>2</sub>OH,  $\geq$ 99.5%, Alfa)], which was added into the abovementioned ITO solution and followed by stirring for 10 h at room temperature in order to process homogeneous hydrolysis and polymerization reaction. The molar ratio of Eu/In and Y/In varied from 0.05/100 to 0.2/100 and 0.5/100 to 4/100, respectively.

## 2.2 Preparation of thin-film coatings

All of the thin films were prepared by sol-gel spin-coating method in a class 100 clean bench. The  $Eu^{3+}-Y^{3+}$  codoped ITO precursor solutions were spin-coated on silica glass substrates of 25 mm×25 mm×0.6 mm dimension (Corning, Eagle 2000). The as-deposited sol-gel films were first dried at 100°C for 10 min, and pyrolyzed in air at 400°C for 10 min at a heating rate of 10°C/min. Finally, the as-formed films were annealed at different temperatures ranging from



600-1000°C for 1 h in air. Multiple spin-coating processes were employed to deposit  $\sim$ 300 nm thick films.

#### 2.3 Characteristic measurements

The crystal structure was determined by an X-ray diffractometer (Shimadzu, XRD 6000). Scanning electron microscopy (Hitachi, S4800-I) was used for microstructural examination. The thickness of  $Eu^{3+}$ -doped ITO films was measured by the SEM cross-sectional image. A monochrometer (Horiba Jobin-yvon, MicroHr) equipped with 300 W Xe lamp (Hamamatasu, L2479) and a 325 nm He-Cd laser with an output power of 4 mW were used as the excitation light source. The visible fluorescence was detected by spectrophotometer (Horiba Jobin-yvon, iHR 550) equipped with a PMT detector (Hamamatasu, 7732P-01) at room temperature. Resistivity of the films was measured by using the four-point probe method (Fluke, 8845A).

#### **3** Results and discussions

#### 3.1 Crystal structures and film morphologies

Figure 1 shows the XRD patterns of ITO film and Eu<sup>3+</sup> (0.1 mol%)-Y<sup>3+</sup> (0, 0.5, 1, 2, and 4 mol%) codoped ITO thin films annealed at 600°C for 1 h. All of the samples possessed the well-crystallized bixbyite phase identified by the characteristic XRD peaks: (222), (400), (440), and (622) [10]. Compared to the diffraction intensity of (222) peak between all samples, the addition of 0.5 mol% Eu<sup>3+</sup> and 0.5-4 mol% Y<sup>3+</sup> ions did not obviously influence the peak intensity of Eu<sup>3+</sup> -Y<sup>3+</sup> codoped ITO thin films, which implies that the slight addition of Eu<sup>3+</sup> and Y<sup>3+</sup> ions with a total concentration of up to 4.1 mol% into the ITO host did not significantly degrade the crystallinity of ITO thin films. The average crystal size was determined by the Scherrer's equation depending on the full width at half maximum (FWHM) of XRD peak [11]. For ITO film and Eu<sup>3+</sup> (0.1 mol%)-Y<sup>3+</sup> (1 mol%) codoped ITO thin films annealed at 600°C for 1 h, the FWHM of (222) peak increased from 0.336° to 0.466° and the average crystal sizes decreased from ~22 to ~19 nm.

On the other hand, all XRD patterns indicate the formation of single bixbyitestructured phase for Eu<sup>3+</sup>-Y<sup>3+</sup> codoped ITO thin films without any possible other phases such as Y<sub>2</sub>O<sub>3</sub>, Eu<sub>2</sub>O<sub>3</sub>, SnO<sub>2</sub>, In<sub>4</sub>Sn<sub>3</sub>O<sub>12</sub>, and Y<sub>2</sub>Sn<sub>2</sub>O<sub>7</sub>. ITO is a kind of solid solution which Sn<sup>4+</sup> concentration of up to 10 mol% can dissolve in In<sub>2</sub>O<sub>3</sub> lattice, resulting in the maximum conductivity [12]. Moreover, In<sub>2</sub>O<sub>3</sub>, Y<sub>2</sub>O<sub>3</sub>, and Eu<sub>2</sub>O<sub>3</sub> possessed the same structures, *i.e.*, bixbyite phase and similar lattice constants (a), as summarized in Table I. Although Eu<sup>3+</sup> and Y<sup>3+</sup> ions in In<sub>2</sub>O<sub>3</sub> lattice to form the solid solution *i.e.*, Y<sub>x</sub>In<sub>2-x</sub>O<sub>3</sub> and Eu<sub>x</sub>In<sub>2-x</sub>O<sub>3</sub>. On the other hand, Eu<sub>2</sub>O<sub>3</sub> and Y<sub>2</sub>O<sub>3</sub> can react with SnO<sub>2</sub> to form the cubic pyrochlore phase, Y<sub>2</sub>Sn<sub>2</sub>O<sub>7</sub> and Eu<sub>2</sub>Sn<sub>2</sub>O<sub>7</sub>. A. Ambrosini *et. al.* investigated that by doping Y<sup>3+</sup> ions into In<sub>2</sub>O<sub>3</sub> lattice, the lattice constant can be enlarged because of Y<sup>3+</sup> ions has larger radius than that of In<sup>3+</sup> ions, which indicates the formation





Figure 1: XRD patterns of ITO film and  $Eu^{3+}$  (0.1 mol%)-Y<sup>3+</sup> (0, 0.5, 1, 2, and 4 mol%) codoped ITO thin films annealed at 600°C for 1 h.

Table 1: Ionic radii and crystallographic data of possible metal oxides in  $Eu^{3+}-Y^{3+}$  codoped ITO thin films.

Oxide	Lattice	Metal ionic	Structure	Reference
	parameters (A)	Taulus(A)	type	PCPDF #
$In_2O_3$	a = 10.11	0.80	Bixbyite	44-1087
VO	a = 10.60	0.90	Bixbyite	PCPDF #
$Y_2O_3$				43-1036
$SnO_2$	a = 4.74 c = 3.19	0.69	Rutile	PCPDF #
				41-1445
$Eu_2O_3$	a = 10.86	0.95	Bixbyite	PCPDF #
				43-1008
Y <sub>2</sub> Sn <sub>2</sub> O <sub>7</sub>	a = 10.37	1.02	Pvrochlore	PCPDF #
1 201-207			- )	20-1418
$In_4Sn_3O_{12}$	a = 9.46		Delta	[21]
	c = 8.86			. J

of solid solution  $Y_yIn_{2-y}O_3$ . In addition, any available  $Y_2O_3$  and  $SnO_2$  in the  $Y^{3+}$ doped ITO system can react with each other to form  $Y_2Sn_2O_7$  until one of the starting materials is completely depleted. The formation of pyrochlore  $Y_2Sn_2O_7$ at 1400°C annealing was detected by XRD even though the content of  $Y^{3+}$  ions is as low as 2 mol% in a  $Sn^{3+}$ -doped  $In_2O_3$  pellet [13]. Fujihara *et. al.* [14] reported that sol-gel derived  $Y_2Sn_2O_7$  thin films were in amorphous state for 500~700°C



annealing; however, the well-defined pyrochlore  $Y_2Sn_2O_7$  thin films were obtained at 800°C or higher annealing temperatures. In our system, annealing temperature was 600°C and hence, the amorphous pyrochlore  $Y_2Sn_2O_7$  can not crystallize to be detected by XRD. Park *et. al.* [15] observed that the pyrochlore phase Eu<sub>2</sub>Sn<sub>2</sub>O<sub>7</sub> was detected in the Eu<sup>3+</sup>-doped SnO<sub>2</sub> thin films annealed at 1200°C for 1 h while the doping concentration reached to 3 mol% [15].

In our experiment even though the light codoping concentration of Eu<sup>3+</sup> and Y<sup>3+</sup> ions is as low as ~4 mol%, the pyrochlore phase should be detected if it forms. However, there is no pyrochlore phase can be detected in Eu<sup>3+</sup>-Y<sup>3+</sup> codoped ITO thin films annealed at 600°C for 1 h. Based on the above-mentioned reported literatures, therefore, the Eu<sup>3+</sup> (0.1 mol%)-Y<sup>3+</sup> (0, 0.5, 1, 2, and 4 mol%) codoped ITO thin films annealed at 600°C for 1 h could be composed of the mixture of amorphous Eu<sub>x</sub>Y<sub>y</sub>Sn<sub>2-x-y</sub>O<sub>7</sub> and crystallized In<sub>2-z</sub>Sn<sub>z</sub>O<sub>3-δ</sub> (δ: oxygen vacancies) phases.

#### **3.2** Fluorescent properties

Fluorescence intensity of the  $Eu^{3+}$ - $Y^{3+}$  codoped ITO thin films with thickness of ~300 nm were found to be extremely low by the excitation of monochrometer equipped with 300 W Xe lamp, which could not be detected due to the limitation of our existing spectrophotometer measurement set-up. However, when the film thickness was up to ~900 nm, the fluorescence intensity was stronger enough to be detected by monochrometer excitation. The ~900 nm thick film appeared to have some cracks, which can not be used for the measurement of sheet resistance but can be used for the measurement of excitation spectrum. Therefore, the fluorescent measurement of all samples with thickness of ~300 nm was executed by using a 325 nm He-Cd laser with an output power of 4 mW as the excitation light source.

Figure 2 shows the emission fluorescence spectra of (a)  $Eu^{3+}$  (0.1 mol%)-Y<sup>3+</sup> (0, 0.5, 1, 2, and 4 mol%) and (b)  $Eu^{3+}$  (0.05, 0.1, and 0.2 mol%)-Y<sup>3+</sup> (1 mol%) codoped ITO thin films annealed at 600°C for 1 h. Obviously, the  $Eu^{3+}$  ions show only one characteristic visible emission, 611 nm red light, which is attributed to the  ${}^{5}D_{0}\rightarrow{}^{7}F_{2}$  transition of  $Eu^{3+}$  ions. Interestingly, no  ${}^{5}D_{0}\rightarrow{}^{7}F_{1}$  transition (~590 nm) of  $Eu^{3+}$  ions can be detected for all samples. It is well known that the probability of intra-4f-f transitions strongly depends on the site

The electric-dipole  ${}^{5}D_{0} \rightarrow {}^{7}F_{2}$  transition is allowed for the Eu<sup>3+</sup> site without inversion symmetry. On the other hand, the Eu<sup>3+</sup> ions can exhibit the magneticdipole  ${}^{5}D_{0} \rightarrow {}^{7}F_{1}$  transition because of the Eu<sup>3+</sup> site with inversion symmetry [16]. In general, both of the electric-dipole and magnetic-dipole transitions coexist in the fluorescent spectra of many Eu<sup>3+</sup>-doped inorganic materials but one is always much stronger than the other. Further, the intensity ratio of the electric-dipole and magnetic-dipole transitions can be used to investigate the asymmetry of Eu<sup>3+</sup> ions in the host lattice site [16]. It is reasonable that only electric-dipole  ${}^{5}D_{0} \rightarrow {}^{7}F_{2}$ transition was observed in our system because Eu<sup>3+</sup> ions is located in the amorphous Eu<sub>x</sub>Y<sub>y</sub>Sn<sub>2-x-y</sub>O<sub>7</sub> lattice site which results in reducing site symmetry of





Figure 2: Emission fluorescence spectra of (a)  $Eu^{3+}$  (0.1 mol%)-Y<sup>3+</sup> (0, 0.5, 1, 2, and 4 mol%) and (b)  $Eu^{3+}$  (0.05, 0.1, and 0.2 mol%)-Y<sup>3+</sup> (1 mol%) codoped ITO thin films annealed at 600°C for 1 h.

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 $Eu^{3+}$  ions, i.e., no inversion symmetry. Similar spectral structure is also observed in other  $Eu^{3+}$ -doped amorphous materials.

The more Eu<sup>3+</sup> or Y<sup>3+</sup> doping concentrations can increase the PL intensity, as shown in Fig. 2 (a) and (b). Because the Eu<sup>3+</sup> (0.05, 0.1, and 0.2 mol%)-Y<sup>3+</sup> (0, 0.5, 1, 2, and 4 mol%) codoped ITO thin films annealed at 600°C for 1 h could be composed of the mixture of amorphous Eu<sub>x</sub>Y<sub>y</sub>Sn<sub>2-x-y</sub>O<sub>7</sub> and crystallized In<sub>2-</sub> <sub>z</sub>Sn<sub>z</sub>O<sub>3-δ</sub> phases, Eu<sup>3+</sup> ions replace Y<sup>3+</sup> ions and are located at the Y<sup>3+</sup> site in Y<sub>2</sub>Sn<sub>2</sub>O<sub>7</sub>. The more Y<sup>3+</sup> ions doped, the more Y<sub>2</sub>Sn<sub>2</sub>O<sub>7</sub> formed, which results in the more Eu<sup>3+</sup> ions can be dissolved in the Y<sub>2</sub>Sn<sub>2</sub>O<sub>7</sub> lattice to reduce the concentration quenching effect and increase the PL intensity.

The excitation spectrum corresponding to the  ${}^{5}D_{0} \rightarrow {}^{7}F_{2}$  transition of Eu<sup>3+</sup> ion in Eu<sup>3+</sup>-Y<sup>3+</sup> codoped ITO thin films annealed at 600°C for 1 h is shown in Figure 3. The broad bands with wavelengths from 350 to 500 nm are ascribed to the f-f transitions of the Eu<sup>3+</sup> ions [17]. Within this broad band, a sharp and strong band at 465 nm can be assigned to the  ${}^{7}F_{0} \rightarrow {}^{5}D_{2}$  transition. Additionally, because the band gap energy of In<sub>2</sub>O<sub>3</sub> nanocrystal is ~4 eV (~300 nm) which is larger than the bulk In<sub>2</sub>O<sub>3</sub> (3.7 eV; ~335 nm), a very small excitation band at 300 nm could be attributed to the energy-transfer transition between Eu<sup>3+</sup> and In<sub>2-</sub> zSn<sub>2</sub>O<sub>3- $\delta$ </sub> [18]. The existence of the excitation band corresponding to the band gap energy is the evidence of energy transfer from the In<sub>2-z</sub>Sn<sub>z</sub>O<sub>3- $\delta$ </sub> nanocrystal to the Eu<sup>3+</sup> ions but the very small In<sub>2-z</sub>Sn<sub>z</sub>O<sub>3- $\delta$ </sub> host band in the excitation spectrum of Eu<sup>3+</sup> indicates that there is a little energy transfer from the In<sub>2-z</sub>Sn<sub>z</sub>O<sub>3- $\delta$ </sub> host to the doped Eu<sup>3+</sup> ions.



Figure 3: Excitation spectrum corresponding to the  ${}^{5}D_{0} \rightarrow {}^{7}F_{2}$  transition of Eu<sup>3+</sup> ion in Eu<sup>3+</sup>-Y<sup>3+</sup> codoped ITO thin films annealed at 600°C/1 h.

On the other hand, the spectrum consists of two very strong broad peaks centered at 207 and 236 nm. It is well known that the charge-transfer transition between Eu<sup>3+</sup> and O<sup>2-</sup> generally occur at 250~260 nm. L.R. Singh reported that because the covalency of Eu-O bonds in  $Y_2O_3$  nanocrystals increases, the Eu-O charge transfer energy can be blue shifted in comparison with that of bulk  $Y_2O_3$  [19]. In our system, the average crystal size of Eu<sup>3+</sup>-Y<sup>3+</sup> codoped ITO thin films annealed at 600°C for 1 h was ~20 nm, which could result in the Eu-O charge transfer energy blue shifting to 236 nm. Moreover, band gap energy of bulk  $Y_2Sn_2O_7$  is 4.45 eV (~279 eV) but because of quantum confinement effect, the band gap energy of nanosized  $Y_2Sn_2O_7$  should be more than 1~2 eV of that value [20]. Therefore, the 207 nm excitation band could be related to the energy-transfer transition between Eu<sup>3+</sup> and  $Y_2Sn_2O_7$  because the Eu<sub>x</sub> $Y_ySn_{2-x-y}O_7$  is amorphous phase with nanosized crystals.

The above-mentioned results reveal that  $Eu^{3+}-Y^{3+}$  codoped ITO thin films annealed at 600°C for 1 h with bixbyite structure can transfer the UV~blue light (200-470 nm) to visible light (611 nm). We believe that  $Eu^{3+}-Y^{3+}$  codoped ITO thin films should have good application in the single crystal or poly crystal Sibased solar cells which have less quantum efficiency in the wavelength range from 300 to 500 nm.



Figure 4: Sheet resistance of  $Eu^{3+}-Y^{3+}$  codoped ITO thin films annealed at 600°C for 1 h as a function of different doping concentrations.

#### 3.3 Electrical properties

The sheet resistance of  $Eu^{3+}-Y^{3+}$  codoped ITO thin films annealed at 600°C for 1 h as a function of different  $Eu^{3+}-Y^{3+}$  doping concentrations is illustrated in Fig. 4. The resistivity of ITO thin films increased up to ~5 % by light  $Y^{3+}$  or  $Eu^{3+}$ doping concentration (0.5 mol%). However, higher doping concentrations can significantly deteriorate the conductivity. For example, for only 1%  $Y^{3+}$  doping concentration the resistivity of ITO thin film was approximately doubled. The addition of  $Eu^{3+}$  and  $Y^{3+}$  ions into ITO lattice can induce the formation of amorphous pyrochlore phase  $Eu_xY_ySn_{2-x-y}O_7$ , an insulator with the energy gap of 4.46 eV, which results in the increase of resistivity. [20] Furthermore, because  $Y^{3+}$  and  $Eu^{3+}$  ions can react with  $Sn^{4+}$  ions to form the pyrochlore phase  $Eu_xY_ySn_{2-x-y}O_7$ , the  $Sn^{4+}$  content in  $In_{2-z}Sn_zO_{3-\delta}$  should be reduced, which also results in the decrease of the carriers created by the dopant and the increase of resistivity.

According to the above-mentioned investigations of luminescence and resistivity properties, the result reveals that there exists a kind of tradeoff between the luminescence and conductivity. It is hard to achieve a  $Eu^{3+}-Y^{3+}$  codoped ITO transparent conductive electrode with both of the high luminescent and high conductivity properties. The  $Eu^{3+}$  and  $Y^{3+}$  codoping concentration should be less than ~0.5% in order to avoid the serious deterioration of conductivity.

## 4 Conclusions

Eu<sup>3+</sup> and Y<sup>3+</sup> ions were codoped into the tin-doped indium oxide transparent conductive electrode to make it possess visible luminescent and conductive properties. The Eu<sup>3+</sup>-Y<sup>3+</sup>codoped ITO transparent conductive thin films with the precise control on the desired stoichiometry of dopants were fabricated by solgel spin-coating technologies. The Eu<sup>3+</sup>-Y<sup>3+</sup> codoped ITO thin films annealed at 600°C for 1 h could be composed of the mixture of amorphous Eu<sub>x</sub>Y<sub>y</sub>Sn<sub>2-x-y</sub>O<sub>7</sub> and crystallized In<sub>2-z</sub>Sn<sub>z</sub>O<sub>3-δ</sub> phases, which results in 611 nm visible luminescence. However, no PL can be detected in Eu<sup>3+</sup>-doped ITO thin films. The higher Y<sup>3+</sup> concentration can increase the PL intensity because of the formation of more Eu<sub>x</sub>Y<sub>y</sub>Sn<sub>2-x-y</sub>O<sub>7</sub>. On the other hand, the Eu<sup>3+</sup> and Y<sup>3+</sup> codoping concentrations should be controlled within ~0.5% to avoid the deterioration of conductivity. The Eu<sup>3+</sup>-Y<sup>3+</sup>codoped ITO thin films should be a good solution as the luminescent solar concentrators to covert the 350~465 nm excited light to 611 nm for the enhancement of solar cell efficiency.

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